Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,794	WEI ET AL.	
Examiner	Art Unit	
David Humphrey	1643	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	ERFERENC	NCE SEARCHED		
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Inventor Search PALM Inventor Sparce WEST	5/12/06 5/12/06	OH OH			
STIC Search (SEQ 10 NO:2)	5/1/06	DH			